

Problem Solutions

Chapter Three: Diodes

P3.1. Consider a p-n junction diode with negligible series resistance. The voltage drop is 0.7 V with a forward current of 5 mA. Determine the reverse saturation current for the case of

- a unity emission coefficient; and
- an emission coefficient of 1.3.

Solution.

a. With $N = 1$,

$$I_S = I \exp\left(-\frac{V}{NkT/q}\right) = (0.005 A) \exp\left(-\frac{0.7V}{26mV}\right) = 1.01 \times 10^{-14} A$$

b. With $N = 1.3$,

$$I_S = I \exp\left(-\frac{V}{NkT/q}\right) = (0.005 A) \exp\left(-\frac{0.7V}{(1.3)(26mV)}\right) = 5.1 \times 10^{-12} A$$

P3.2. Consider diodes with unity emission coefficients and negligible series resistance.

Determine the reverse saturation current for

- a p-n junction which exhibits a voltage drop of 0.7 V at a forward current of 1 mA; and
- a Schottky diode which exhibits a voltage drop of 0.3 V at a forward current of 1 mA.

Solution.

a. For the p-n junction, assuming room temperature and a unity emission coefficient,

$$I_S = (10^{-3} A) \exp(-0.7V / 0.026V) = 2.0 \times 10^{-15} A$$

b. For the Schottky diode, assuming room temperature and a unity emission coefficient,

$$I_S = (10^{-3} A) \exp(-0.3V / 0.026V) = 9.7 \times 10^{-9} A$$

P3.3. Suppose a diode has a unity emission coefficient. Determine the change in the forward bias voltage which will cause a ten-fold increase in the forward current.

Solution. Using the diode equation,

$$10 = \frac{I_S e^{qV_2/kT}}{I_S e^{qV_1/kT}}$$

Solving,

$$\Delta V = V_2 - V_1 = \frac{kT}{q} \ln(10) = 60mV.$$

P3.4. Consider a Si p⁺-n junction at 300 K with $N_a = 10^{18} \text{ cm}^{-3}$ and $N_d = 10^{16} \text{ cm}^{-3}$. The junction area is 10^{-5} cm^2 . Determine

- the built-in potential;
- the zero-bias depletion width; and
- the zero-bias depletion capacitance.

Solution.

a. The built-in potential is

$$V_{bi} = \frac{kT}{q} \ln \left[\frac{(10^{18} \text{ cm}^{-3})(10^{16} \text{ cm}^{-3})}{(1.45 \times 10^{10} \text{ cm}^{-3})^2} \right] = 0.82V$$

b. The zero-bias depletion width is

$$W = \sqrt{\frac{2(11.9)(8.85 \times 10^{-14} \text{ F/cm})(0.82 \text{ V})}{(1.602 \times 10^{-19} \text{ C})(10^{16} \text{ cm}^{-3})}} = 0.33 \mu\text{m}.$$

c. The zero-bias depletion capacitance is

$$C_0 = \frac{(11.9)(8.85 \times 10^{-14} \text{ F/cm})(10^{-5} \text{ cm}^2)}{0.33 \times 10^{-4} \text{ cm}} = 0.32 \text{ pF}.$$

P3.5. Consider a Si p^+n junction at 300 K with $N_a = 2 \times 10^{18} \text{ cm}^{-3}$ and $N_d = 10^{16} \text{ cm}^{-3}$. The junction area is $3.2 \times 10^{-6} \text{ cm}^2$. Determine and plot $1/C^2$ versus the reverse bias voltage.

Solution. The built-in potential is

$$V_{bi} = \frac{kT}{q} \ln \left[\frac{(10^{18} \text{ cm}^{-3})(10^{16} \text{ cm}^{-3})}{(1.45 \times 10^{10} \text{ cm}^{-3})^2} \right] = 0.82 \text{ V}.$$

The depletion width with a reverse bias V_r is given by

$$W = \sqrt{\frac{2(11.9)(8.85 \times 10^{-14} \text{ F/cm})(0.82 \text{ V} + V_r)}{(1.602 \times 10^{-19} \text{ C})(10^{16} \text{ cm}^{-3})}} = 0.33 \mu\text{m} \sqrt{1 + V_r / 0.82 \text{ V}}.$$

The depletion capacitance with a reverse bias V_r is given by

$$C = \frac{\epsilon A}{W} = \frac{(11.9)(8.85 \times 10^{-14} \text{ F/cm})(3.2 \times 10^{-6} \text{ cm}^2)}{0.33 \times 10^{-4} \text{ cm} \sqrt{1 + V_r / 0.82 \text{ V}}} = \frac{0.102 \text{ pF}}{\sqrt{1 + V_r / 0.82 \text{ V}}}.$$

The results are plotted in Figure 3.20.

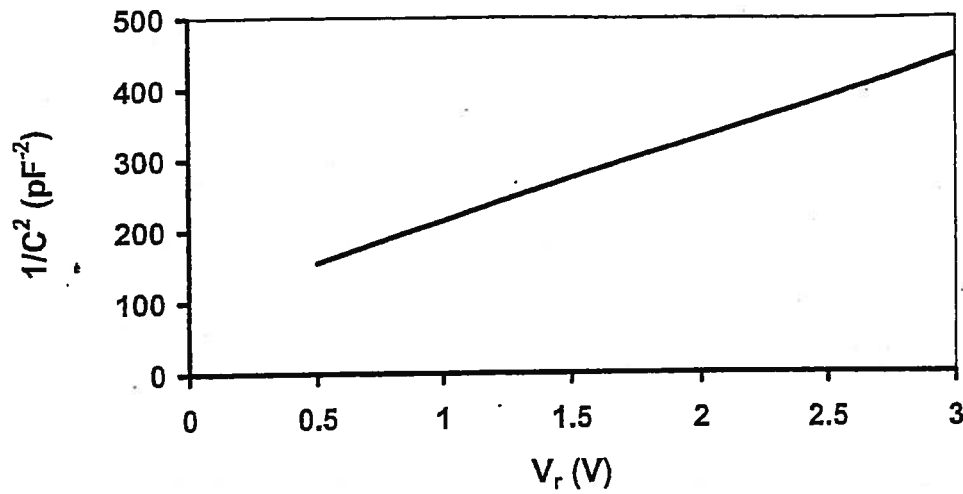


Figure 3.20.

P3.6. Consider the p-n junction shown in Figure 3.19. $T = 300\text{K}$.

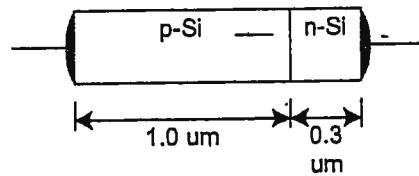


Figure 3.19.

The material parameters are given in Table 3.3, and the junction area is 10^{-5} cm^2 .

Table 3.3.

p-Si	n-Si
$N_a = 10^{15}\text{ cm}^{-3}$	$N_d = 10^{18}\text{ cm}^{-3}$
$D_n = 25\text{ cm}^2\text{ s}^{-1}$	$D_p = 8\text{ cm}^2\text{ s}^{-1}$
$\tau_n = 20\text{ ns}$	$\tau_p = 3\text{ ns}$

- a. Determine the reverse saturation current.

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- b. Determine the bias voltage at a forward current of 1 mA, assuming the emission coefficient is unity.

Solution. This is an n^+p junction, so the conduction will be dominated by the injection of electrons into the quasi neutral p-type region. The diffusivity for electrons on the p-type side is given to be $D_{np} = 25 \text{ cm}^2 \text{ s}^{-1}$. Therefore the minority carrier diffusion length is

$$L_{np} = \sqrt{D_{np} \tau_{np}} = \sqrt{(25 \text{ cm}^2 \text{ s}^{-1})(20 \text{ ns})} = 7.1 \mu\text{m}.$$

Therefore $L_{np} \gg W_B$ and this is a short base diode.

- a. The reverse saturation current is given by

$$I_S \approx \frac{qAD_n n_i^2}{N_a W_B} = \frac{(1.6 \times 10^{-19} \text{ C})(10^{-5} \text{ cm}^2)(25 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1})(1.45 \times 10^{10} \text{ cm}^{-3})^2}{(10^{15} \text{ cm}^{-3})(10^{-4} \text{ cm})} = 8.4 \times 10^{-14} \text{ A}$$

- b. The bias voltage which will result in 1 mA of forward current is

$$V = \frac{kT}{q} \ln\left(\frac{I}{I_S}\right) = 0.026 \text{ V} \ln\left(\frac{10^{-3} \text{ A}}{8.4 \times 10^{-14} \text{ A}}\right) = 0.60 \text{ V}$$